

FDT459N

N-Channel Enhancement Mode Field Effect Transistor

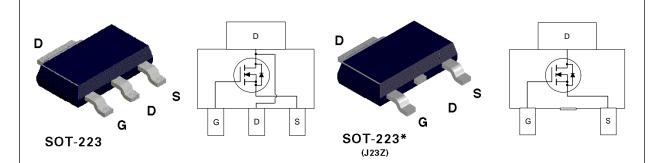
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance, provide superior switching performance. These products are well suited to low voltage, low current applications such as notebook computer power management, battery powered circuits, and DC motor control.

Features

- 6.5 A, 30 V. $R_{DS(ON)} = 0.035\Omega$ @ $V_{GS} = 10$ V $R_{DS(ON)} = 0.055~\Omega$ @ $V_{GS} = 4.5$ V.
- High density cell design for extremely low R_{DS(ON)}.
- High power and current handling capability in a widely used surface mount package.





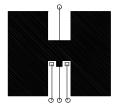
Absolute Maximum Ratings $T_A = 25^{\circ}\text{C}$ unless otherwise noted

| Parameter | | FDT459N | Units |
|--|---|---|---|
| Drain-Source Voltage | | 30 | V |
| Gate-Source Voltage - Continuous | | ±20 | V |
| Maximum Drain Current - Continuous (Note 1a) | | 6.5 | А |
| - Pulsed | | 20 | |
| Maximum Power Dissipation | (Note 1a) | 3 | W |
| | (Note 1b) | 1.3 | |
| | (Note 1c) | 1.1 | |
| Operating and Storage Temperature Range | | -55 to 150 | °C |
| L CHARACTERISTICS | | | • |
| Thermal Resistance, Junction-to-Am | bient (Note 1a) | 42 | °C/W |
| Thermal Resistance, Junction-to-Ca | SE (Note 1) | 12 | °C/W |
| | Drain-Source Voltage Gate-Source Voltage - Continuous Maximum Drain Current - Continuou | Drain-Source Voltage Gate-Source Voltage - Continuous Maximum Drain Current - Continuous - Pulsed Maximum Power Dissipation (Note 1a) (Note 1b) (Note 1c) Operating and Storage Temperature Range L CHARACTERISTICS Thermal Resistance, Junction-to-Ambient (Note 1a) | Drain-Source Voltage 30 Gate-Source Voltage - Continuous ±20 Maximum Drain Current - Continuous (Note 1a) 6.5 - Pulsed 20 Maximum Power Dissipation (Note 1a) (Note 1b) (Note 1b) 1.3 (Note 1c) 1.1 1.1 Operating and Storage Temperature Range -55 to 150 L CHARACTERISTICS Thermal Resistance, Junction-to-Ambient (Note 1a) 42 |

^{*} Order option J23Z for cropped center drain lead.

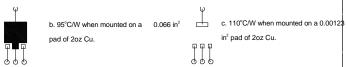
| Symbol | Parameter | Conditions | | Min | Тур | Max | Units |
|-------------------------------------|---|---|--|-----|-------|-------|-------|
| OFF CHAR | ACTERISTICS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$ | | 30 | | | V |
| ΔBV _{DSS} /ΔT _J | Breakdown Voltage Temp. Coefficient | $I_D = 250 \mu\text{A}$, Referenced to | I _D = 250 μA, Referenced to 25 °C | | 33 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 24 V, V _{GS} = 0 V | | | | 1 | μA |
| | | | T _J =55°C | | | 10 | μA |
| GSSF | Gate - Body Leakage, Forward | $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | | 100 | nA |
| GSSR | Gate - Body Leakage, Reverse | $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | | -100 | nA |
| ON CHARA | CTERISTICS (Note 2) | | | | | | |
| / _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$ | | 1 | 1.6 | 2 | V |
| $\Delta V_{GS(th)}/\Delta T_{J}$ | Gate Threshold Voltage Temp.Coefficient | $I_D = 250 \mu\text{A}$, Referenced to | 25 °C | | -4.2 | | mV/°C |
| | Static Drain-Source On-Resistance | $V_{GS} = 10 \text{ V}, I_{D} = 6.5 \text{ A}$ | | | 0.031 | 0.035 | Ω |
| | | | T _J =125°C | | 0.044 | 0.06 | |
| | | $V_{GS} = 4.5 \text{ V}, I_D = 5.5 \text{ A}$ | | | 0.046 | 0.055 | |
| D(ON) | On-State Drain Current | $V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$ | | 20 | | | Α |
| Fs | Forward Transconductance | $V_{DS} = 10 \text{ V}, I_{D} = 6.5 \text{ A}$ | | | 16 | | S |
| OYNAMIC C | CHARACTERISTICS | | | | | | |
| iss | Input Capacitance | $V_{DS} = 15 \text{ V}, \ V_{GS} = 0 \text{ V},$ f = 1.0 MHz | | | 365 | | pF |
| oss | Output Capacitance | | | | 210 | | pF |
| rss | Reverse Transfer Capacitance | | | | 70 | | pF |
| WITCHING | G CHARACTERISTICS (Note 2) | | | | | | |
| D(on) | Turn - On Delay Time | $V_{DD} = 15 \text{ V}, \ I_D = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \ R_{GEN} = 6 \Omega$ | | | 5.2 | 11 | ns |
| | Turn - On Rise Time | | | | 8.2 | 16 | ns |
| O(off) | Turn - Off Delay Time | | | | 6 | 12 | ns |
| | Turn - Off Fall Time | | | | 16 | 26 | ns |
| Q_g | Total Gate Charge | $V_{DS} = 10 \text{ V}, I_{D} = 6.5 \text{ A},$ $V_{GS} = 10 \text{ V}$ | | | 12 | 17 | nC |
| Q_{gs} | Gate-Source Charge | | | | 2.2 | | nC |
| Q_{gd} | Gate-Drain Charge | | | | 3 | | nC |
| RAIN-SOL | IRCE DIODE CHARACTERISTICS AND MA | XIMUM RATINGS | | | | T | |
| S | Maximum Continuous Drain-Source Diode Forward Current | | | | | 2.5 | Α |
| / _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 2.5 \text{ A} \text{ (Note 2)}$ | | | 8.0 | 1.2 | V |

Typical $R_{_{\theta^{J\!A}}}$ using the board layouts shown below on $\,$ FR-4 PCB in a still air environment:



a. 42°C/W when mounted on a 1 in² pad of 2oz Cu.





Scale 1: 1 on letter size paper

2. Pulse Test: Pulse Width $\leq 300 \mu s$, Duty Cycle $\leq 2.0\%$

^{1.} $R_{g,u}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{g,c}$ is guaranteed by design while $\boldsymbol{R}_{\text{\tiny BCA}}$ is determined by the user's board design.

Typical Electrical Characteristics

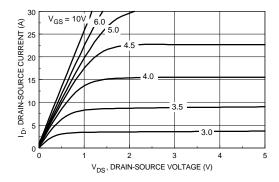


Figure 1. On-Region Characteristics.

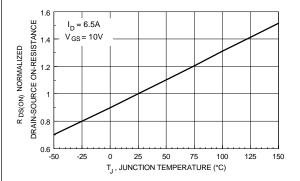


Figure 3. On-Resistance Variation with Temperature.

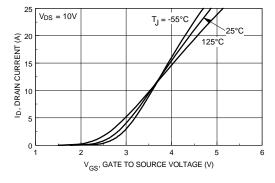


Figure 5. Transfer Characteristics.

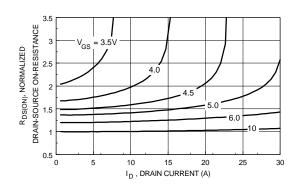


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

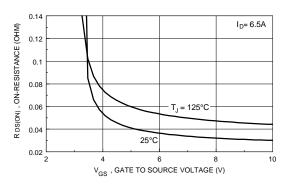


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

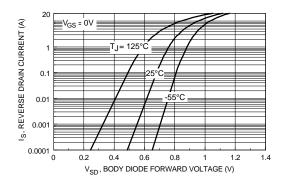


Figure 6. Body Diode Forward Voltage
Variation with Source Current
and Temperature.

Typical Electrical Characteristics

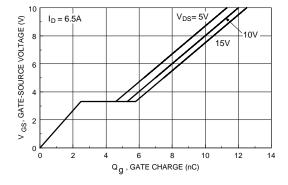


Figure 7. Gate Charge Characteristics.

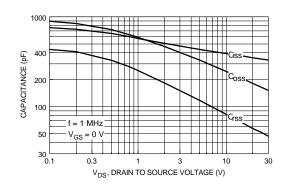


Figure 8. Capacitance Characteristics.

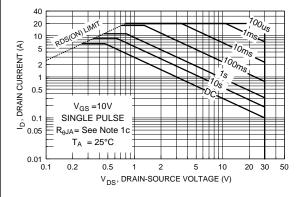


Figure 9. Maximum Safe Operating Area.

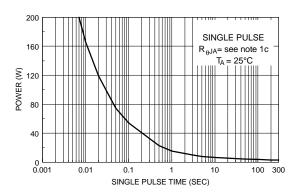


Figure 10. Single Pulse Maximum Power Dissipation.

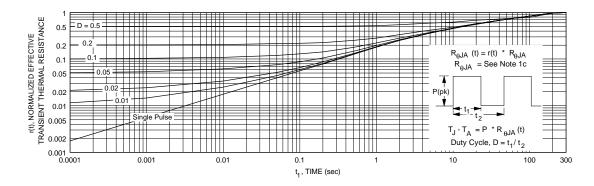


Figure 11. Transient Thermal Response Curve.

Note: Thermal characterization performed using the conditions described in note 1c. Transient thermal response will change depending on the circuit board design.

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